

Docket No.: W&B-INF-1850

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : CARSTEN OHLHOFF ET AL.
Filed : CONCURRENTLY HERewith
Title : TEST CIRCUIT AND METHOD FOR TESTING AN INTEGRATED
MEMORY CIRCUIT

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

U.S. Patent No. 6,539,505 B1 (Dähn), dated March 25, 2003, and corresponding German Published Non-Prosecuted Patent Application DE 199 22 786 A1 (Dähn), dated December 7, 2000.

Respectfully submitted,



For Applicants

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Date: July 3, 2003

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FORM PTO-1449 (SUBSTITUTE) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))				Attorney Docket No.: W&B-INF-1850 Appl. No.: <hr/> Applicant: CARSTEN OHLHOFF ET AL. <hr/> Filing Date: July 3, 2003 Group Art Unit:			
EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
	A	6,539,505 B1	3/25/03	Dähn			
	B						
	C						
	D						
	E						
	F						
	G						
	H						
	I						
FOREIGN PATENT DOCUMENT							
		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES NO
	J	199 22 786 A1	12/7/00	Germany			
	K						
	L						
	M						
	N						
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
EXAMINER				DATE CONSIDERED			